Giant x-ray multiphoton ionization of atoms and molecules.

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Ne: 63

12

1.7 fs

(ke

Abstract

Interaction of atoms and molecules with intense x-ray free-electron laser (XFEL) pulses is characterized by sequential multiphoton multiple ionization. This sequential ionization model has been verified with a series of gas-phased atomic XFEL experiments. With recent advances of XFELs, we are able to reach extremely high peak intensity in the hard x-ray regime, which gives rise to new multiphoton phenomena that have not been observed with x-ray synchrotron radiation. In this contribution, I will discuss two recent studies of enhancement of x-ray multiphoton ionization: REXMI and CREXIM. First, **REXMI** stands for resonance-enabled or resonance-enhanced x-ray multiple ionization. Due to the broad energy bandwidth of XFEL pulses and multiple resonant excitations followed by Auger-like decays, the system can be further ionized, far beyond the prediction of the straightforward sequential multiphoton ionization model. In our recent experiment with heavy atoms, the charge-state distribution as an outcome of ionization dynamics shows not only a dramatic extension to high charge states but also a characteristic pattern in the extended ion yields, which can be explained only when both relativistic and resonance effects are taken into account in theory Next, **CREXIM** represents charge-rearrangement-enhanced x-ray ionization of molecules. When a molecule consisting of heavy and light atoms is exposed to high-intensity XFEL pulses, the molecule can be further ionized, far beyond the prediction of the independentatom model. We propose a mechanism behind molecular x-ray ionization enhancement as the repetition of single-photon absorption on heavy atoms accompanied with electron transfer from light atoms to heavy atoms via chemical bonding. I will present two case studies: Xe atom for REXMI and iodomethane molecule for CREXIM. We employ dedicated theoretical tools, **XATOM** and **XMOLECULE**, and we make a quantitative comparison with our recent experimental results. For both cases, we demonstrate that highly nonlinear behavior is exhibited and the degree of ionization is no longer proportional to photoionization cross section at high x-ray intensity. These two ionization enhancement mechanisms can play an important role for the quantitative understanding of radiation damage dynamics during ultraintense hard x-ray pulses.

X-ray multiphoton ionization







Young et al., Nature **466**, 56 (2010).

Interaction of matter with intense XFEL pulses is characterized by sequential multiphoton multiple ionization dynamics.

- > First LCLS experiment of Ne: fundamental atomic physics in XFEL
- > Sequence of K-shell ionization (P), Auger decay (A), and fluorescence (F)
- > Extremely complicated ionization dynamics
- > Highly excited electronic structure involved
- > No standard quantum chemistry code available

Multiphoton multiple ionization mechanism Ionization thresholds of Xe ions 41 fs Photoionization Auger/Coster-Kronig Fluorescence 1.3 fs



REXMI: Resonance-enabled or -enhanced x-ray multiple ionization, now with relativistic effects







- > REXMI dramatically enhances the degree of ionization by multiple resonant excitations and autoionization of multiply excited states with the help of a large bandwidth of XFEL pulses. > Resonance effect
- > one resonance channel: Xiang et al., PRA 86, 061401 (2012).
- > multiple resonance channels: Ho et al., PRL 113, 253001 (2014); PRA 92, 063430 (2015).
- > Relativistic energy correction within first-order perturbation theory
- > open new Coster-Kronig decay channels > close photoionization channels earlier > the closer to photon energy, the higher cross
- section
- > Both resonance and relativistic effects are implemented in XATOM: Ref. [8].
- > Numerical complexity for Xe with n_{max} =30 and $I_{\text{max}}=7 \rightarrow 10^{68}$ electronic configurations to be considered!

10¹³

Ref. [9]

CREXIM: Charge-rearrangement-enhanced x-ray ionization of molecules

Xe@5.5 keV

20

Ref. [5]

15

Charge states







We implement an integrated toolkit, XATOM, to treat x-ray-induced processes based on nonrelativistic quantum electrodynamics and perturbation theory within the Hartree–Fock–Slater model. To simulate ionization dynamics in intense x-ray pulses, we employ the rate equation approach with photoionization cross sections, Auger rates, and fluorescence rates, for all possible *n*-hole electronic configurations for all possible +*n* charge states.



We develop an x-ray molecular physics toolkit, XMOLECULE. The molecular electronic structure is solved within the Hartree-Fock-Slater model with core-hole-adapted basis functions calculated by XATOM. To describe ionization dynamics, coupled rate equations are solved with a Monte Carlo approach. To describe fragmentation dynamics, the nuclear motions are propagated classically during each kinetic Monte Carlo trajectory, with molecular forces, rates and cross-sections calculated on the fly from a given electronic configuration and molecular geometry.



Main developers: Zoltan Jurek, Malik M. Abdullah, and Beata Ziaja

Conclusions

- > Enabling tools to investigate x-ray multiphoton physics of atoms and molecules exposed to intense XFEL pulses
- > Nonlinear behavior of atomic and molecular responses to intense x-rays
- > Dramatic enhancement of x-ray multiphoton ionization via resonance and molecular environment
- > Interplay of resonance and relativistic effects for Xe: First quantitative comparison for REXMI in atoms at high x-ray intensity
- > Molecular ionization enhancement (CREXIM) for CH_3I and C_6H_5I :
- First quantitative comparison for molecular ionization at high x-ray intensitv
- > New phenomena to be taken into account for future XFEL applications

Collaboration

Experimental team

Kansas State Univ. S. J. Robatjazi, X. Li, D. Rolles, A. Rudenko

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- > XMDYN: X-ray molecular dynamics > classical dynamics for ions and free electrons > guantum treatment for bound electrons -> combined with XATOM > First validation with LCLS (C₆₀) and SACLA (Ar/Xe clusters) experiments
- > Murphy et al., Nat. Commun. 5, 4281 (2014).
- > Tachibana *et al.*, *Sci. Rep.* **5**, 10977 (2015).
- > Start-to-end simulation for single-particle imaging at European XFEL
- > Yoon et al., Sci. Rep. 6, 24791 (2016).
- > Fortmann-Grote *et al.*, *IUCrJ* **4**, 560 (2017).
- > Chemical dynamics (oligomer formation) in Ar clusters > Kumagai *et al.*, *Phys. Rev. Lett.* **120**, 223201 (2018).

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